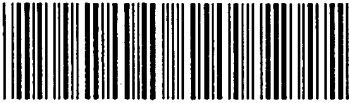


Search Notes

Application/Control No.

10/634,971

Examiner

Hai C. Pham

Applicant(s)/Patent under
Reexamination

IKEDA ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
347	5-13, 37, 39, 73-77	6/20/2005	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
347	11	6/20/2005	HP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/20/2005	HP